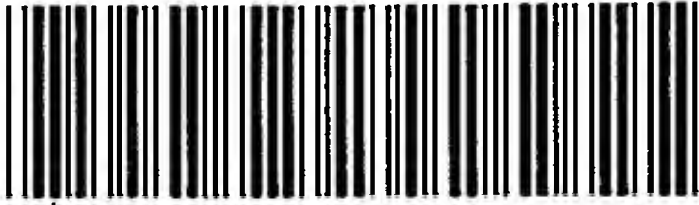


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/711,007	LAPEYRE ET AL.	
	Examiner	Art Unit	
	Mark A. Deuble	3651	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
SEE SRWF 3/9/2005		6/20/2005	MD

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
SEARCH UPDATED	6/20/2005	MD